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IS 11298 (Part 3/Sec 1): 1991

भारतीय मानक

विद्युत प्रयोजनों के लिए प्लास्टिक फिल्म - विशिषिट

भाग 3 श्रलग-श्रलग सामग्री

अनुभाग 1 संघारित्रों के लिए पॉलीप्रोपाइलीन फिल्म

(पहला पुनरीक्षण)

Indian Standard

PLASTIC FILMS FOR ELECTRICAL PURPOSES — SPECIFICATION

PART 3 SPECIFICATIONS FOR INDIVIDUAL MATERIALS

Section 1 Polypropylene Films for Capacitors

(First Revision)

UDC 621:315:616:96-416: (678:742:3): 621:319:4

@ BIS 1991

BUREAU OF INDIAN STANDARDS MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG NEW DELHI 110002

FOREWORD

This Indian Standard (Part 3/Sec 1) was adopted by the Bureau of Indian Standards, after the draft finalized by the Solid Electrical Insulating Materials Sectional Committee had been approved by the Eelectrotechnical Division Council.

This standard is one of the series of Indian Standards which deals with plastic films for electrical purposes. The series consists of the following three parts:

- Part 1 Definitions and general requirements;
- Part 2 Methods of test; and
- Part 3 Specifications for individual materials.

This standard covers the requirements for polypropylene films for capacitors.

The first revision of the standard has been undertaken to take care of the experience and feedback received from the industry.

In the preparation of this standard, assistance has been derived from IEC Doc: 15C (Central Office) 143 'Specification for plastic films for electrical purposes: Part 3 Specification for individual materials. Sheet 1 Requirements for polypropylene films for capacitors, issued by the International Electrotechnical Commission (IEC).

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated, expressing the result of a test or analysis, shall be rounded off in accordance with IS 2: 1960 'Rules for rounding off numerical values (revised)'. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

Indian Standard

PLASTIC FILMS FOR ELECTRICAL PURPOSES — SPECIFICATION

PART 3 SPECIFICATIONS FOR INDIVIDUAL MATERIALS

Section 1 Polypropylene Films for Capacitors

(First Revision)

1 SCOPE

1.1 This standard (Part 3/Sec 1) covers the requirements of plain and hazy polypropylene films (non-metallized) for capacitors. The material shall be made from polypropylene homopolymer and shall conform to IS 11298 (Part 1): 1985, unless otherwise specified in this standard.

2 REFERENCES

2.1 The following Indian Standards are necessary adjuncts to this Standard:

IS No.

4905: 1968 Methods for random sampling

Specification for plastic films for (Part 1): 1985 electrical purposes: Part 1 Defi-

nitions and general requirements

Title

11298 Specification for plastic films for (Part 2): 1987 electrical purposes: Part 2

Methods of tests

3 TERMINOLOGY

3.1 For the purpose of this standard, the definitions given in IS 11298 (Part 1): 1985 shall apply.

4 GENERAL REQUIREMENTS

- 4.1 All materials in a consignment shall comply with the requirements given in IS 11298 (Part 1): 1985.
- 4.2 The join of the film shall be at not more than one place for a length of the film up to 1 000 metres. Each roll shall not contain more than two joins. A bright coloured pressure sensitive adhesive tape visible from both ends of the roll shall be used so that the position of the join is easily known to the operator.

4.3 Alignment of Core

The width of the core shall not be less than that of the film.

4.4 Telescoping

The axial shifting of sections of the slit roll relative to other annular sections shall be as follows:

Up to 150 mm width : 0.5 mm maximum
Beyond 150 mm width : 1.0 mm maximum

4.5 Shiner in the Slit Roll

The shiner is a misalignment of one or more turns which displays a shining appearance. Shiners may be allowed at the start of a slit roll or at a join, but they shall not exceed 1 mm.

4.6 Camber in the Slit Roll

For widths up to 380 mm, the camber should not exceed 3 mm when a film 1.5 metre in length is laid on a smooth flat surface.

4.7 Surface of the Film in Slit Rolls

The surface of the film shall be uniform and nonblocking. It shall be free from line marks, particulate matter, blisters, wrinkles and ripples so as to be functionally acceptable. The optical properties shall be consistent from roll to roll.

4.8 Resin

The film shall be manufactured from virgin, electrical grade polypropylene resin of isotactic content not less than 94 percent.

4.9 Orientation

The film shall be fully oriented so as to have balanced physical properties.

4.10 Sag in the Slit Roll

The procedure for the determination of sag has been outlined in 7.3.3 of IS 11298 (Part 2): 1987.

The sag so measured shall not exceed one percent of the width of the slit roll employed for measurement

NOTE — The sag should not hinder the smooth winding of the film during capacitor manufacturing.

4.11 Curl on the Slit Roll

The plain polypropylene film shall lay flat when unwound. For the hazy polypropylene film, the flatness is under consideration.

4.12 Shiny Band in the Slit Rolls

In hazy film bends are not desirable. The maximum allowable limit of shiny bend in hazy film is subject to agreement between the purchaser and the supplier.

5 ROUTINE/ACCEPTANCE TESTS

- 5.1 The following tests shall be carried out to check the conformity or otherwise of the material with respect to the stipulated requirements given in 4 and 6:
 - a) Inspection of general requirements (see 4),
 - b) Thickness,
 - c) Space factor,
 - d) Width,
 - e) Outside diameter,
 - f) Density,
 - g) Tensile strength,
 - h) Elongation,
 - i) Shrinkage,
 - k) Dielectric strength,
 - m) Volume resistivity,
 - n) Dissipation factor,
 - p) Dielectric constant, and
 - q) Electrical weak spots.

6 PERFORMANCE REQUIREMENTS

6.1 When tested according to the relevant methods described in IS 11298 (Part 2): 1987, the material shall conform to the requirements given in Table 1,

6.2 Liquid Adsorption

For satisfactory construction of impregnated capacitors the adsorption of the impregnant by the film may need to be controlled within certain limits. If required, the method of measurement, the time and temperature used, and the adsorption limits shall be agreed between the supplier and the purchaser. The preferred method shall be as given in 32 of IS 11298 (Part 2): 1987.

6.3 Compatibility with Impregnants

The compatibility of the film with selected dielectric fluids shall be determined using a method, agreed upon between the supplier and the purchaser. This method may, for example, be based on swelling or solubility of the film in the fluid on contamination of the fluid or the film.

6.4 Dissipation Factor Under Impregnated Conditions

The impregnants and the methods of testing used throughout the capacitor industry vary widely and many of the materials and procedures are proprietary.

Where dissipation factor of film under impregnated conditions must be to an agreed standard, the limiting values and the method of measurement must be agreed between the supplier and the purchaser.

NOTE — In consideration of the wide variety of impregnants today available and under development for capacitor application, no specific tests and/ or limits can be given in this standard, for example, see 6.2 for liquid adsorption, 6.3 for specification compatibility with dielectric fluids, and 6.4 for dissipation factor under impregnated conditions.

Table 1 Propertywise Requirements for the Rough (Hazy) and Plain Polypropylene Film (Applicable to Slit Rolls Only)

(Clause 6.1)

Sì	Property	Clause Ref. of	Requirements		Tolerance	Remarks	
No		IS 11298 (Part 2)-1987			- v	6 T C C C C C C C C C C C C C C C C C C	
(1)	(2)	(3)	(4)		(5)	(6)	
1.	Thickness in microns	4.5	Preferred thickness a) For plain film:—6, 8, 10, 12, 14, 15.2, 16.5 18 and 20		±6%	Only micrometer thick- ness shall be considered	
			b) For Hazy 8, 9, 10,		±6%	Only weight thickness shall be considered	
2.	Space factor for hazy film (percent)	4.5	10		±2	The space factor calculated on each of the ten micrometer reading shall be within 5-16 percent	
3.	Width in mm	8	Perferred widths are not given on account of the great variety of capacitors in which the films are to be used		±0.5 mm up to 150 mm ±1.0 mm above 150 mm width	The width of the film is a subject of agreement between the purchaser and the supplier	
4.	Roll outside diameter in mm		20	200			
5. 6.	Density (gm/cm ³) Tensile strength at break (N/mm ³)	6.1.2 12	0 905 140		±0.005 Minimum specified	Rate of travel of the tensometer should be 100 mm/minute	
	i) along MD ii) along CMD	<u>}</u>					
7.	Elongation at break both along MD and CMD (percent)	12	4	10	Minimum Specified		
8.	Heat shrinkage (perce i) along MD	nt): 24		4	Maximum	Test conditions:	
9.	ii) along CMD DC Diclectric strength (volts/micron) Breakdown voltage (kV/mm)		Nominal thickness in microns	2 Minimum individual	Maximum Average	100°C for 10 minutes The rate of rise of voltage shall be 500 volts sec	
10.	Volume resistivity (in ohm-cm) at 27±2°C and 60±5% RH	n 16	6 8-11 ≥12 1 ×	250 300 450 1016	350 400 525 Minimum specified value	The value shall be computed on the basis of 50 observations Film thick- ness (in voltage applicable (in volts)	
						<10 50 too	
11.	Dissipation factor at 27°C 48-52 Hz and 500 volts AC	17	2 ×	10-4	Number Maximum specified value	results shall be reported, The sample size shall be such, as to suit the elec-	
12,	Dielectric constant at 27°C and 48-52 Hz	17	2.2		±0·05	rodes employed	
13.	Electrical weakspots (counts/5 m ²)	20	Nominal film thick-ness in microns 6 8 and 9 10 and 11	Maximum No. of per. missible weak spots measured over a film area of 5m ² 6 4 3 2	Maximum specified value	The test voltage to be applied shall be 200 V DC per micron based on the nominal thickness of the film, Sensitivity shall be specified	

NOTE 1 — Each and every slit roll shall be marked with weight thickness calculated from the net weight or the slit roll, length and assumed density of 0.905 gm per cubic cm.

NOTE 2 — For a lot of more than one ton, the average weight thickness shall not vary by more than ± 5 percent of the nominal value.

NOTE 3 — For determining the space factor for hazy films, micrometer and weight thickness shall be measured on the same sample of a slit roll.

NOTE 4 — Sampling plan shall be as per Annex A.

ANNEX A

(Table 1, Note 4)

SAMPLING PLAN

A-1 SAMPLING

A-1.1 Lot

All the slit rolls of the same size manufactured from the same material under similar conditions of production shall be grouped together to constitute a lot.

A-1.2 The number of slit rolls to be selected from each lot shall depend upon the size of the lot and shall be in accordance with columns 1 and 2 of Table 2. These slit rolls shall be selected from the lot at random. In order to ensure the randomness of selection, procedure given in IS 4905: 1968 (Methods for random sampling) shall be followed.

A-1.3 Criteria for Conformity

The slit rolls selected at random according to columns 1 and 2 of Table 2 shall be subjected to each of the tests. A slit roll failing to satisfy the requirement of any of these tests shall be termed

as defective. The lot shall be considered as conforming to these requirements if the number of defectives found in the sample is less than or equal to the corresponding permissible number given in column 3 of Table 2, otherwise the lot shall be rejected.

Table 2 Sample Size and Premissible Number of Defectives

Lot Size	Sample Size	Permissible Number of Defectives	
(1)	(2)	(3)	
Up to 50	5	0	
51 to 100	8	0 .	
101 to 300	13	1	
301 to 500	20	1	
501 to 1 000	32	2	
1 001 and above	50	3	

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